

New Jersey Semi-Conductor Products, Inc.

20 STERN AVE.
SPRINGFIELD, NEW JERSEY 07081
U.S.A.

TELEPHONE: (973) 376-2922
(212) 227-6005
FAX: (973) 376-8960

2N3728

NPN HIGH PERFORMANCE DIFFERENTIAL AMPLIFIERS

- $\text{hFE}_1 \dots 0.9\text{-}1.0$ FROM 100 μA to 1.0 mA @ 25°C , 0.8-1.0 FROM 100 μA to 1.0 mA, -55°C to $+125^\circ\text{C}$
 hFE_2
- $|\text{V}_{\text{BE}1}\text{-}\text{V}_{\text{BE}2}| \dots 3.0$ mV (MAX) FROM 100 μA to 1.0 mA
- $|\Delta\text{V}_{\text{BE}}| \dots 10$ $\mu\text{V}/^\circ\text{C}$ (MAX) FROM 100 μA to 1.0 mA, -55°C to $+125^\circ\text{C}$

ABSOLUTE MAXIMUM RATINGS (Note 1)

Maximum Temperatures

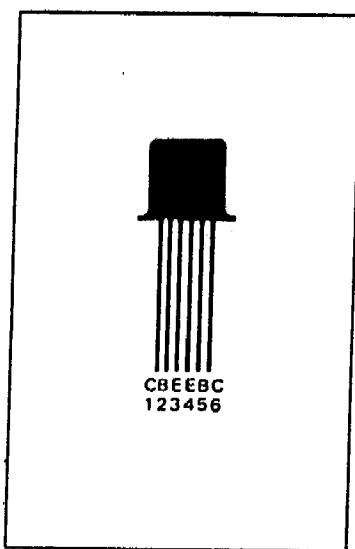
Storage Temperature	-65°C to $+200^\circ\text{C}$	
Operating Junction Temperature	200°C	
Lead Temperature (60 seconds)	300°C	

Maximum Power Dissipation (Notes 2 & 3)

	One Side	Both Sides
Total Dissipation at 25°C Case Temperature	1.0 W	1.6 W
at 100°C Case Temperature	0.67 W	0.91 W
at 25°C Ambient Temperature	0.45 W	0.55 W

Maximum Voltages and Current

V_{CEO}	Collector to Base Voltage	60 V
V_{CEO}	Collector to Emitter Voltage (Note 4)	30 V
V_{EBO}	Emitter to Base Voltage	5.0 V
I_{C}	Collector Current	500 mA
V_{C1C2}	Collector ₁ to Collector ₂ Voltage Voltage Rating any Lead to Case	± 200 V



ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted) (Cont'd.)

SYMBOL	CHARACTERISTIC	MIN.	MAX.	UNITS	TEST CONDITIONS
h_{FE}	DC Current Gain	30			$I_C = 0.1 \text{ mA}, V_{CE} = 5.0 \text{ V}$
		45	180		$I_C = 1.0 \text{ mA}, V_{CE} = 5.0 \text{ V}$
		80	280		$I_C = 150 \text{ mA}, V_{CE} = 5.0 \text{ V}$ (Note 6)
$V_{CEO(sus)}$	Collector to Base Breakdown Voltage	60			$I_C = 10 \mu\text{A}, I_E = 0$
	Emitter to Base Breakdown Voltage	5.0			$I_C = 0, I_E = 10 \mu\text{A}$
	Collector to Emitter Sustaining Voltage (Notes 4 & 6)	30			$I_C = 10 \text{ mA}, I_B = 0$
$V_{CE(sat)}$	Collector Saturation Voltage (Note 6)		0.22	V	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$
$V_{BE(sat)}$	Base Saturation Voltage (Note 6)		1.1	V	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$
			10	nA	$I_E = 0, V_{CB} = 50 \text{ V}$
			10	μA	$I_E = 0, V_{CB} = 50 \text{ V}, T_A = 150^\circ\text{C}$
I_{EBO}	Emitter Cutoff Current		10	nA	$I_C = 0, V_{EB} = 3.0 \text{ V}$
			10	nA	$I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 20 \text{ MHz}$
			2.5	6.0	$I_C = 50 \text{ mA}, V_{CE} = 10 \text{ V}, f = 100 \text{ MHz}$
C_{ob}	Common Base, Open Circuit, Output Capacitance		8.0	pF	$I_E = 0, V_{CB} = 10 \text{ V}, f = 140 \text{ kHz}$
			20	pF	$I_C = 0, V_{EB} = 2.0 \text{ V}, f = 140 \text{ kHz}$
C_{ib}	Common Base, Open Circuit, Input Capacitance				
			1.2	6.0	$I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 1.0 \text{ kHz}$
			300	$\times 10^{-6}$	$I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 1.0 \text{ kHz}$
h_{ie}	Input Impedance		20		$I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 1.0 \text{ kHz}$
			50		$I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 1.0 \text{ kHz}$
			200		$I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 1.0 \text{ kHz}$
h_{re}	Reverse Voltage Feedback Ratio		7.0		$I_C = 0.1 \text{ mA}, V_{CE} = 5.0 \text{ V}, f = 15.7 \text{ kHz}$
			50		3.0 dB pts. @ 25 Hz and 10 kHz, $R_S = 1.0 \text{ k}\Omega$
			200		
h_{oe}	Output Conductance				
			50		
			200		
h_{fe}	Forward Current Transfer Ratio				
			50		
			200		
NF	Wide Band Noise Figure		7.0		
			50		
			200		
h_{FE1}	DC Current Gain Ratio (Note 5)	0.8	1.0		$I_C = 100 \mu\text{A} \text{ to } 1.0 \text{ mA}, V_{CE} = 5.0 \text{ V}$
$ V_{BE1}-V_{BE2} $	Base to Emitter Voltage Differential		5.0	mV	$I_C = 100 \mu\text{A} \text{ to } 1.0 \text{ mA}, V_{CE} = 5.0 \text{ V}$
$ \Delta(V_{BE1}-V_{BE2}) $	Base to Emitter Voltage Differential		1.6	mV	$I_C = 100 \mu\text{A} \text{ to } 1.0 \text{ mA}, V_{CE} = 5.0 \text{ V}$
			(20 μV/°C)		$T_A = -55^\circ\text{C} \text{ to } +25^\circ\text{C}$
$ \Delta(V_{BE1}-V_{BE2}) $	Base to Emitter Voltage Differential		2.0	mV	$I_C = 100 \mu\text{A} \text{ to } 1.0 \text{ mA}, V_{CE} = 5.0 \text{ V}$
			(20 μV/°C)		$T_A = +25^\circ\text{C} \text{ to } +125^\circ\text{C}$

NOTES:

- These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- These ratings give maximum junction temperature of 200°C and junction to ambient thermal resistance of 384°C/W (derating factor of 2.57 mW/°C) for one side; 318°C/W (derating factor of 3.14 mW/°C) for both sides; junction to case thermal resistance of 175°C/W (derating factor of 5.71 mW/°C) for one side; 109°C/W (derating factor of 9.15 mW/°C) for both sides.
- Rating refers to a high current point where collector to emitter voltage is lowest.
- Lowest of two h_{FE} readings is taken as h_{FE1} for purposes of this ratio.
- Pulse conditions: length = 300 μs; duty cycle = 1%.